HIGH-SPEED 3.3V 512K x 18 **SYNCHRONOUS BANK-SWITCHABLE DUAL-PORT STATIC RAM** WITH 3.3V OR 2.5V INTERFACE

Features:

- 512K x 18 Synchronous Bank-Switchable Dual-ported **SRAM Architecture**
 - 64 independent 8K x 18 banks
 - 9 megabits of memory on chip
- Bank access controlled via bank address pins

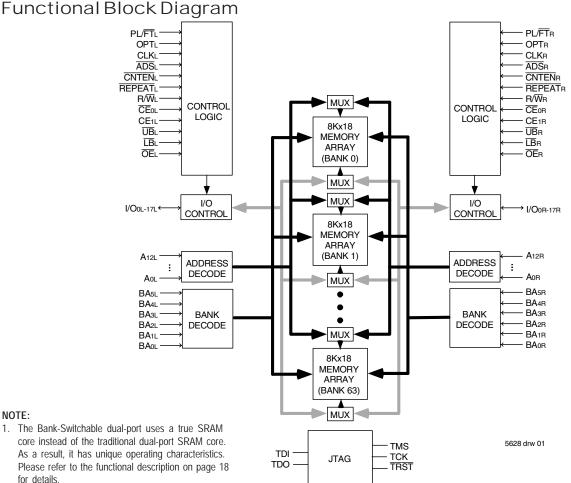
RENESAS

- High-speed data access
 - Commercial: 3.4ns (200MHz)/3.6ns (166MHz)/ 4.2ns (133MHz) (max.)
 - Industrial: 3.6ns (166MHz)/4.2ns (133MHz) (max.)
- Selectable Pipelined or Flow-Through output mode
- Counter enable and repeat features
- Dual chip enables allow for depth expansion without additional logic
- Full synchronous operation on both ports
 - 5ns cycle time, 200MHz operation (14Gbps bandwidth)
 - Fast 3.4ns clock to data out

1.5ns setup to clock and 0.5ns hold on all control, data, and address inputs @ 200MHz

70V7339S

- Data input, address, byte enable and control registers
- Self-timed write allows fast cycle time
- Separate byte controls for multiplexed bus and bus matching compatibility
- LVTTL- compatible, 3.3V (±150mV) power supply for core
- LVTTL compatible, selectable 3.3V (±150mV) or 2.5V (±100mV) power supply for I/Os and control signals on each port
- Industrial temperature range (-40°C to +85°C) is available at 166MHz and 133MHz
- Available in 208-pin fine pitch Ball Grid Array (fpBGA) and 256-pin Ball Grid Array (BGA)
- Supports JTAG features compliant with IEEE 1149.1
- ٠ Green parts available, see ordering information



OCTOBER 2019

NOTE:

for details.

70V7339S High-Speed 512K x 18 Synchronous Bank-Switchable Dual-Port Static RAM

Industrial and Commercial Temperature Ranges

Description:

The IDT70V7339 is a high-speed 512Kx18 (9Mbit) synchronous Bank-Switchable Dual-Ported SRAM organized into 64 independent 8Kx18 banks. The device has two independent ports with separate control, address, and I/O pins for each port, allowing each port to access any 8Kx18 memory block not already accessed by the other port. Accesses by the ports into specific banks are controlled via the bank address pins under the user's direct control.

Registers on control, data, and address inputs provide minimal setup and hold times. The timing latitude provided by this approach allows systems to be designed with very short cycle times. With an input data

register, the IDT70V7339 has been optimized for applications having unidirectional or bidirectional data flow in bursts. An automatic power down feature, controlled by CE0 and CE1, permits the on-chip circuitry of each port to enter a very low standby power mode. The dual chip enables also facilitate depth expansion.

The 70V7339 can support an operating voltage of either 3.3V or 2.5V on one or both ports, controllable by the OPT pins. The power supply for the core of the device(VDD) remains at 3.3V. Please refer also to the functional description on page 18.

A1	A2	A3	A4	A5	ag	A7	A8	^{A9}	A10	A11	A12	A13	A14	^{A15}	A16	A17
IO9L	NC	Vss	TDO	NC	B A 3l	A12L	A8L	NC	Vdd	CLKL	CNTENL	A 4L	A0L	OPTL	NC	Vss
B1	B2	^{B3}	^{B4}	^{B5}	B6	B7	B8	B9	B10	^{B11}	B12	B13	B14	B15	b16	^{B17}
NC	VSS	NC	TDI	BA4L	BA0L	A9L	NC	CE0L	Vss	ADSL	A5L	A1L	VSS	Vddqr	I/O8l	NC
C1	C2	c3	C4	C5	C6	C7	C8	C9	C10	C11	C12	C13	C14	C15	C16	C17
Vddql	I/O9R	Vddqr	PL/FTL	BA5L	BA1L	A10L	UBL	CE1L	Vss	R/WL	A6L	A2L	VDD	I/O8R	NC	Vss
D1	D2	d3	D4	d5	D6	D7	d8	d9	D10	D 1 1	D12	D13	D14	d15	d16	d17
NC	Vss	I/O10L	NC	BA2l	A11L	A7L	TBL	Vdd	OEL	REPEATL	A3L	Vdd	NC	Vddql	I/O7l	I/O7r
e1 I/O11L	E2 NC	e3 Vddqr	e4 I/O10r		-	-			-				e14 I/O6l	E15 NC	E16 Vss	E17 NC
f1 Vddql	f2 I/O11R	F3 NC	F4 Vss										F14 Vss	f15 I/O6r	F16 NC	f17 Vddqr
G1 NC	G2 Vss	G3 I/O12L	G4 NC										G14 NC	g15 Vddql	g16 I/O5l	G17 NC
H1 Vdd	^{H2} NC	h3 Vddqr	h4 I/O12R				В)V73(F208	(5)				H14 Vdd	H15 NC	H16 Vss	h17 I/O5r
j1 Vddql	J2 Vdd	_{J3} Vss	_{J4} Vss				BF	G20	8 ⁽⁵⁾				J14 Vss	J15 Vdd	J16 Vss	j17 Vddqr
k1 I/O14R	K2 Vss	k3 I/O13r	^{K4} Vss					Pin fp Viev		l.			k14 I/O3r	k15 Vddql	к16 I/O4r	K17 Vss
L1 NC	l2 I/O14L	l3 Vddqr	l4 I/O13L				104						L14 NC	l15 I/O3l	L16 Vss	l17 I/O4l
M1	M2	m3	M4							M14	M15	^{M16}	M17			
Vddql	NC	I/O15r	Vss							Vss	NC	I/O2r	Vddqr			
N1 NC	N2 Vss	N3 NC	N4 I/O15L										n14 I/O1r	n15 Vddql	N16 NC	N17 I/O2L
P1	p2	p3	P4	^{P5}	^{Р6}	P7	P8	P9	P10	P11	P12	P13	P14	Р15	P16	P17
I/O16R	I/O16L	Vddqr	NC	TRST	ВАзк	A12R	A8R	NC	Vdd	CLKr	CNTENR	A4R	NC	I/O1L	Vss	NC
R1	R2	r3	^{R4}	r5	r6	R7	R8	r9	R10	^{R11}	R12	R13	R14	r15	r16	r17
Vss	NC	I/O17r	TCK	BA4r	BAor	A9R	NC	CE0r	Vss	ADSr	A 5R	A1R	Vss	Vddql	I/Oor	Vddqr
T1	t2	t3	^{T4}	t5	t6	T7	t8	T9	^{T10}	t11	T12	T13	^{T14}	T15	^{T16}	T17
NC	I/O17L	Vddql	TMS	BA5r	BA1r	A10R	UBr	CE1R	Vss	R/Wr	A 6R	A2R	Vss	NC	Vss	NC
U1	^{U2}	uз	U4	U5	U6	U7	u8	U9	U10	U11	U12	U13	U14	U15	U16	U17
Vss	NC	PL/FTr	NC	BA2R	A11R	A7R	LBr	Vdd	OEr	REPEATR	A3R	Aor	VDD	OPTR	NC	I/Ool

PinConfiguration^(1,2,3,4)

NOTES:

1. All VDD pins must be connected to 3.3V power supply.

- 3. All Vss pins must be connected to ground supply.
- 4. Package body is approximately 15mm x 15mm x 1.4mm with 0.8mm ball pitch.
- This package code is used to reference the package diagram. 5. 6.
 - This text does not indicate orientation of the actual part-marking

5628 drw 02c

^{2.} All VDDQ pins must be connected to appropriate power supply: 3.3V if OPT pin for that port is set to ViH (3.3V), and 2.5V if OPT pin for that port is set to VIL (OV).

70V7339S High-Speed 512K x 18 Synchronous Bank-Switchable Dual-Port Static RAM

Pin Configuration^(1,2,3,4) (con't.)

70V7339 BC256⁽⁵⁾ BCG256⁽⁵⁾

256-Pin BGA Top View⁽⁶⁾

A1	^{A2}	A3	A4	^{A5}	A6	A7	A8	A9	A10	A11	A12	A13	A14	A15	A16
NC	TDI	NC	BA4L	BA1L	A11L	A8L	NC	CE1L	OEL	CNTENL	A 5L	A 2L	A0L	NC	NC
^{B1}	B2	^{B3}	B4	^{B5}	B6	B7	b8	B9	^{B10}	bii	B12	B13	B14	B15	^{B16}
NC	NC	TDO	BA5L	BA2L	A12L	A9L	UBl	CE0L	R∕₩L	Repeatl	A 4L	A1L	Vdd	NC	NC
C1	C2	C3	C4	C5	C6	C7	C8	C9	C10	C11	C12	С13	C14	C15	C16
NC	I/O9L	Vss	BA3L	BA0L	A10L	A7L	NC	TBL	CLKL	ADSL	A6L	Аз∟	OPT∟	NC	I/O8L
D1	d2	D3	d4	d5	d6	d7	d8	d9	d10	d11	d12	D13	D14	D15	D16
NC	I/O9r	NC	PL/FTL	Vddql	Vddql	Vddqr	Vddqr	Vddql	Vddql	Vddqr	Vddqr	Vdd	NC	NC	I/O8R
e1	e2	E3	e4	e5	e6	e7	E8	^{E9}	E10	e11	E12	e13	E14	e15	e16
I/O10r	I/O10L	NC	Vddql	Vdd	Vdd	Vss	Vss	Vss	Vss	Vdd	Vdd	Vddqr	NC	I/O7l	I/O7r
f1	F2	^{f3}	f4	^{f5}	^{F6}	F7	^{F8}	^{F9}	F10	F11	F12	f13	f14	F15	F16
I/O11L	NC	I/O11r	Vddql	Vdd	Vss	Vss	Vss	Vss	Vss	Vss	Vdd	Vddqr	I/О6r	NC	I/O6L
G1	G2	G3	G4	G5	G6	G7	_{G8}	^{G9}	G10	G11	G12	g13	G14	G15	G16
NC	NC	I/O12L	Vddqr	Vss	Vss	Vss	Vss	Vss	Vss	Vss	Vss	Vddql	I/ O 5L	NC	NC
H1	h2	H3	h4	H5	H6	H7	H8	H9	H10	H11	H12	h13	^{H14}	H15	h16
NC	I/O12R	NC	Vddqr	Vss	Vss	Vss	Vss	Vss	Vss	Vss	Vss	Vddql	NC	NC	I/O5r
J1	J2	j3	j4	J5	_{J6}	_{J7}	_{J8}	_{J9}	J10	J11	J12	j13	J14	j15	J16
I∕O13L	I/O14R	I/O13R	Vddql	Vss	Vss	Vss	Vss	Vss	Vss	Vss	Vss	Vddqr	I/O4r	I/O3r	I/O4L
кı	K2	кз	k4	K5	K6	к7	K8	к9	K10	K11	K12	k13	K14	к15	к16
NC	NC	I/O14L	Vddql	Vss	Vss	Vss	Vss	Vss	Vss	Vss	Vss	Vddqr	NC	NC	І/Оз∟
l1	L2	l3	l4	l5	L6	L7	L8	L9	L10	L11	l12	l13	l14	L15	l16
I/O15L	NC	I/O15R	Vddqr	Vdd	Vss	Vss	Vss	Vss	Vss	Vss	Vdd	Vddql	I/O2l	NC	I/O2R
м1	M2	M3	^{m4}	M5	M6	M7	M8	M9	M10	M11	M12	m13	^{M14}	м15	M16
I/O16R	I/O16L	NC	Vddqr	Vdd	Vdd	Vss	Vss	Vss	Vss	VDD	Vdd	Vddql	I/O1r	I/O1L	NC
N1 NC	N2 I/O17R	N3 NC	№ PL/FTr	N5 Vddqr	^{N6} Vddqr	n7 Vddql	n8 Vddql	^{N9} Vddqr		N11 Vddql	n12 Vddql		N14 NC	n15 I/O0r	N16 NC
P1	Р2	P3	^{Р4}	P5	P6	P7	P8	^{P9}	P10	P11	P12	Р13	P14	P15	P16
NC	I/O17L	TMS	ВАзв	BA0R	A10R	A 7R	NC	TBr	CLKR	ADSR	A 6R	А ЗR	NC	NC	I/Ool
^{R1}	R2	^{R3}	R4	^{R5}	R6	R7	r8	R9	^{R10}	r11	R12	R13	^{R14}	R15	R16
NC	NC	TRST	BA5R	BA2R	A12R	A 9R	UBr	CE0R	R/WR	REPEATR	A 4R	A 1R	OPTR	NC	NC
T1	T2	T3	^{T4}	T5	т6	T7	T8	^{T9}	T10	t11	T12	T13	T14	^{T15}	^{т16}
NC	TCK	NC	BA4r	BA 1R	А 11R	A 8R	NC	CE1R	OEr	CNTENR	A 5R	A 2R	A 0R	NC	NC

NOTES:

1. All VDD pins must be connected to 3.3V power supply.

2. All VDDD pins must be connected to appropriate power supply: 3.3V if OPT pin for that port is set to VIH (3.3V), and 2.5V if OPT pin for that port is set to VIL (0V).

3. All Vss pins must be connected to ground supply.

- 4. Package body is approximately 17mm x 17mm x 1.4mm, with 1.0mm ball-pitch.
- 5. This package code is used to reference the package diagram.

6. This text does not indicate orientation of the actual part-marking.

5628 drw 02d

70V7339S

High-Speed 512K x 18 Synchronous Bank-Switchable Dual-Port Static RAM

Pin Names

Left Port	Right Port	Names
CE 0l, CE1l	CEOR, CE1R	Chip Enables
R/WL	R/Wr	Read/Write Enable
ŌĒL	0 Er	Output Enable
BAOL - BA5L	BAOR - BASR	Bank Address ⁽⁴⁾
Aol - A12l	Aor - A12r	Address
1/Ool - 1/O17L	I/Oor - I/O17r	Data Input/Output
CLKL	CLKr	Clock
PL/ FT ∟	PL/FTr	Pipeline/Flow-Through
ADSL	ADS R	Address Strobe Enable
		Counter Enable
REPEATL	REPEATR	Counter Repeat ⁽³⁾
<u>LB</u> L, <u>UB</u> L	\overline{LB} R, $\overline{U}\overline{B}$ R	Byte Enables (9-bit bytes)
VDDQL	Vddqr	Power (I/O Bus) (3.3V or 2.5V) ⁽¹⁾
OPTL	OPTR	Option for selecting VDDax ^(1,2)
	Vdd	Power (3.3V) ⁽¹⁾
	Vss	Ground (0V)
	TDI	Test Data Input
	TDO	Test Data Output
	TCK	Test Logic Clock (10MHz)
	TMS	Test Mode Select
Ī	TRST	Reset (Initialize TAP Controller)

5628 tbl 01

Industrial and Commercial Temperature Ranges

- VDD, OPTx, and VDDox must be set to appropriate operating levels prior to applying inputs on the I/Os and controls for that port.
- 2. OPTx selects the operating voltage levels for the I/Os and controls on that port. If OPTx is set to VIH (3.3V), then that port's I/Os and controls will operate at 3.3V levels and VDDox must be supplied at 3.3V. If OPTx is set to VIL (0V), then that port's I/Os and address controls will operate at 2.5V levels and VDDox must be supplied at 2.5V. The OPT pins are independent of one another—both ports can operate at 3.3V levels, both can operate at 2.5V levels, or either can operate at 3.3V with the other at 2.5V.
- 3. When REPEAT x is asserted, the counter will reset to the last valid address loaded via ADS x.
- 4. Accesses by the ports into specific banks are controlled by the bank address pins under the user's direct control: each port can access any bank of memory with the shared array that is not currently being accessed by the opposite port (i.e., BA0L BA5L ≠ BA0R BA5R). In the event that both ports try to access the same bank at the same time, neither access will be valid, and data at the two specific addresses targeted by the ports within that bank may be corrupted (in the case that either or both ports are writing) or may result in invalid output (in the case that both ports are trying to read).

70V7339S High-Speed 512K x 18 Synchronous Bank-Switchable Dual-Port Static RAM

Industrial and Commercial Temperature Ranges

Truth Table I—Read/Write and Enable Control^(1,2,3,4)

OE ³	CLK	Ē₽	CE1	ŪB	LΒ	R/W	Upper Byte I/O9-17	Lower Byte I/O0-8	MODE
Х	Ŷ	Н	Х	Х	Х	Х	High-Z	High-Z	Deselected-Power Down
Х	Ŷ	Х	L	Х	Х	Х	High-Z	High-Z	Deselected-Power Down
Х	Ŷ	L	Н	Н	Н	Х	High-Z	High-Z	All Bytes Deselected
Х	Ŷ	L	Н	Н	L	L	High-Z	Din	Write to Lower Byte Only
Х	Ŷ	L	Н	L	Н	L	Din	High-Z	Write to Upper Byte Only
Х	\uparrow	L	Н	L	L	L	Din	Din	Write to both Bytes
L	\uparrow	L	Н	Н	L	Н	High-Z	Dout	Read Lower Byte Only
L	\uparrow	L	Н	Ц	Н	Н	Dout	High-Z	Read Upper Byte Only
L	\uparrow	L	Н	L	L	Н	Dout	Dout	Read both Bytes
Н	Х	Х	Х	Х	Х	Х	High-Z	High-Z	Outputs Disabled

NOTES:

1. "H" = VIH, "L" = VIL, "X" = Don't Care.

2. ADS, CNTEN, REPEAT are set as appropriate for address access. Refer to Truth Table II for details.

3. OE is an asynchronous input signal.

4. It is possible to read or write any combination of bytes during a given access. A few representative samples have been illustrated here.

Address	Previous Address	Addr Used	CLK	ADS	CNTEN	REPEAT ⁽⁶⁾	I/O ⁽³⁾	MODE
An	Х	An	\uparrow	L ⁽⁴⁾	Х	Н	Dvo (n)	External Address Used
Х	An	An + 1	Ŷ	Н	L ⁽⁵⁾	Н	Dvo(n+1)	Counter Enabled—Internal Address generation
Х	An + 1	An + 1	Ŷ	Н	Н	Н	Dvo(n+1)	External Address Blocked—Counter disabled (An + 1 reused)
Х	Х	An	\uparrow	Х	Х	L ⁽⁴⁾	Dvo (0)	Counter Set to last valid ADS load

Truth Table II—Address and Address Counter Control^(1,2,7)

5628 tbl 03

NOTES: 1. "H" = VIH, "L" = VIL, "X" = Don't Care.

2. Read and write operations are controlled by the appropriate setting of R/W, CEo, CE1, UB/LB and OE.

3. Outputs configured in flow-through output mode: if outputs are in pipelined mode the data out will be delayed by one cycle.

4. ADS and REPEAT are independent of all other memory control signals including CEo, CE1 and UB/LB

5. The address counter advances if CNTEN = VIL on the rising edge of CLK, regardless of all other memory control signals including CE0, CE1, UB/LB.

6. When REPEAT is asserted, the counter will reset to the last valid address loaded via ADS. This value is not set at power-up: a known location should be loaded via ADS during initialization if desired. Any subsequent ADS access during operations will update the REPEAT address location.

7. The counter includes bank address and internal address. The counter will advance across bank boundaries. For example, if the counter is in Bank 0, at address FFFh, and is advanced one location, it will move to address 0h in Bank 1. By the same token, the counter at FFFh in Bank 63 will advance to 0h in Bank 0. Refer to Timing Waveform of Counter Repeat, page 17. Care should be taken during operation to avoid having both counters point to the same bank (i.e., ensure BAoL - BAsL ≠ BAoR - BAsR), as this condition will invalidate the access for both ports. Please refer to the functional description on page 18 for details.

5628 tbl 02

70V7339S High-Speed 512K x 18 Synchronous Bank-Switchable Dual-Port Static RAM

Industrial and Commercial Temperature Ranges

5628 tb1 05a

Recommended Operating Temperature and Supply Voltage⁽¹⁾

Grade	Ambient Temperature	GND	Vdd
Commercial	0°C to +70°C	0V	3.3V <u>+</u> 150mV
Industrial	-40°C to +85°C	0V	3.3V <u>+</u> 150mV

NOTE:

1. This is the parameter TA. This is the "instant on" case temperature.

Absolute Maximum Ratings⁽¹⁾

Symbol	Rating	Commercial & Industrial	Unit
Vterm ⁽²⁾	Terminal Voltage with Respect to GND	-0.5 to +4.6	V
Tbias	Temperature Under Bias	-55 to +125	٥C
Tstg	Storage Temperature	-65 to +150	٥C
Ιουτ	DC Output Current	50	mA
NOTEO			5628 tbl 06

NOTES:

 Stresses greater than those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

2. VTERM must not exceed VDD + 150mV for more than 25% of the cycle time or 4ns maximum, and is limited to \leq 20mA for the period of VTERM \geq VDD + 150mV.

Recommended DC OperatingConditions with VDDQ at 2.5V

Symbol	Parameter	Min.	Тур.	Мах.	Unit
Vdd	Core Supply Voltage	3.15	3.3	3.45	V
VDDQ	I/O Supply Voltage ⁽³⁾	2.4	2.5	2.6	V
Vss	Ground	0	0	0	V
Vih	Input High Voltage (Address & Control Inputs)	1.7		Vddq + 100mV ⁽²⁾	V
V⊮	Input High Voltage - I/O ⁽³⁾	1.7		$V_{DDQ} + 100 mV^{(2)}$	V
Vil	Input Low Voltage	-0.3(1)		0.7	V

NOTES:

5628 tbl 04

1. Undershoot of VIL $_{\geq}$ -1.5V for pulse width less than 10ns is allowed.

2. VTERM must not exceed VDDQ + 100mV.

 To select operation at 2.5V levels on the I/Os and controls of a given port, the OPT pin for that port must be set to VIL (0V), and VDDOX for that port must be supplied as indicated above.

Recommended DC OperatingConditions with VDDQ at 3.3V

Parameter	Min.	Тур.	Мах.	Unit
Core Supply Voltage	3.15	3.3	3.45	V
I/O Supply Voltage ⁽³⁾	3.15	3.3	3.45	V
Ground	0	0	0	V
Input High Voltage (Address & Control Inputs) ⁽³⁾	2.0		Vddq + 150mV ⁽²⁾	V
Input High Voltage - I/O ⁽³⁾	2.0		VDDQ + 150mV ⁽²⁾	V
Input Low Voltage	-0.3(1)		0.8	V
	Core Supply Voltage I/O Supply Voltage ⁽³⁾ Ground Input High Voltage (Address & Control Inputs) ⁽³⁾ Input High Voltage - I/O ⁽³⁾	Core Supply Voltage3.15I/O Supply Voltage ⁽³⁾ 3.15Ground0Input High Voltage (Address & Control Inputs) ⁽⁶⁾ 2.0Input High Voltage - I/O ⁽³⁾ 2.0	Core Supply Voltage 3.15 3.3 I/O Supply Voltage ⁽³⁾ 3.15 3.3 Ground 0 0 Input High Voltage Control Inputs) ⁽³⁾ 2.0 — Input High Voltage - I/O ⁽³⁾ 2.0 —	Core Supply Voltage 3.15 3.3 3.45 I/O Supply Voltage ⁽³⁾ 3.15 3.3 3.45 Ground 0 0 0 Input High Voltage K Control Inputs ⁽³⁾ 2.0 VDDQ + 150mV ⁽²⁾ Input High Voltage - VO ⁽³⁾ 2.0 VDDQ + 150mV ⁽²⁾

NOTES:

- 1. Undershoot of VIL \geq -1.5V for pulse width less than 10ns is allowed.
- 2. VTERM must not exceed VDDQ + 150mV.
- 3. To select operation at 3.3V levels on the I/Os and controls of a given port, the OPT pin for that port must be set to VIH (3.3V), and VDDOX for that port must be supplied as indicated above.

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70V7339S High-Speed 512K x 18 Synchronous Bank-Switchable Dual-Port Static RAM

Industrial and Commercial Temperature Ranges

5628 tbl 08

Capacitance⁽¹⁾

 $(TA = +25^{\circ}C, F = 1.0MHz) PQFP ONLY$

	Symbol	Parameter	Conditions ⁽²⁾	Мах.	Unit
	Cin	Input Capacitance	VIN = 3dV	8	pF
Γ	Cout ⁽³⁾	Output Capacitance	Vout = 3dV	10.5	pF
					5628 tbl 07

NOTES:

1. These parameters are determined by device characterization, but are not production tested.

2. 3dV references the interpolated capacitance when the input and output switch from 0V to 3V or from 3V to 0V.

3. Cout also references Ci/o.

DC Electrical Characteristics Over the Operating Temperature and Supply Voltage Range ($V_{DD} = 3.3V \pm 150 \text{mV}$)

			70V7	/339S	
Symbol	Parameter	Test Conditions	Min.	Max.	Unit
lu	Input Leakage Current ⁽¹⁾	$V_{DDQ} = Max., V_{IN} = 0V$ to V_{DDQ}		10	μA
ILO	Output Leakage Current ⁽¹⁾	\overline{CE}_{0} = ViH or CE1 = ViL, Vout = 0V to VDD2		10	μA
Vol (3.3V)	Output Low Voltage ⁽²⁾	IOL = +4mA, $VDDQ = Min$.		0.4	V
Voн (3.3V)	Output High Voltage ⁽²⁾	IOH = -4mA, VDDQ = Min.	2.4	_	V
Vol (2.5V)	Output Low Voltage ⁽²⁾	IOL = +2mA, $VDDQ = Min$.		0.4	V
Voн (2.5V)	Output High Voltage ⁽²⁾	IOH = -2mA, VDDQ = Min.	2.0	_	V

NOTES:

1. At VDD \leq 2.0V leakages are undefined.

2. VDDQ is selectable (3.3V/2.5V) via OPT pins. Refer to page 4 for details.

70V7339S High-Speed 512K x 18 Synchronous Bank-Switchable Dual-Port Static RAM

Industrial and Commercial Temperature Ranges

DC Electrical Characteristics Over the Operating Temperature and Supply Voltage Range⁽⁵⁾ ($V_{DD} = 3.3V \pm 150 \text{mV}$)

						9S200 ⁽⁷⁾ I Only	Co	9S166 ⁽⁶⁾ m'I Ind	Co	39S133 m'l Ind	
Symbol	Parameter	Test Condition	Versio	on	Тур. ⁽⁴⁾	Мах.	Тур. ⁽⁴⁾	Мах.	Тур. ⁽⁴⁾	Мах.	Unit
ĺdd	Dynamic Operating	\overline{CE}_{L} and $\overline{CE}_{R=}$ VIL,	COM'L	S	815	950	675	790	550	645	mA
	Current (Both Ports Active)	Outputs Disabled, f = fMAX ⁽¹⁾	IND	S		_	675	830	550	675	
ISB1	Standby Current	$\overline{CE}L = \overline{CE}R = VIH$	COM'L	S	340	410	275	340	250	295	mA
	(Both Ports - TTL Level Inputs)	$f = fMAX^{(1)}$	IND	S	_	_	275	355	250	310	
ISB2	Standby Current	$\overline{CE}^{"}A^{"} = VIL and \overline{CE}^{"}B^{"} = VIH^{(3)}$	COM'L	S	690	770	515	640	460	520	mA
	(One Port - TTL Level Inputs)	Active Port Outputs Disabled, f=fMAX ⁽¹⁾	IND	S	_	_	515	660	460	545	
ISB3	Full Standby Current	Both Ports $\overline{CE}L$ and $\overline{CE}R \ge VDDQ - 0.2V$,	COM'L	S	10	30	10	30	10	30	mA
	(Both Ports - CMOS Level Inputs)	$ \begin{array}{l} \text{VIN} \geq \text{VDDQ} \ \text{-} \ 0.2 \text{V} \ \text{or} \ \text{VIN} \leq 0.2 \text{V}, \\ f = 0^{(2)} \end{array} $	IND	S	_	_	10	40	10	40	
ISB4	Full Standby Current (One Port - CMOS	$\overline{CE}^*A^* \le 0.2V$ and $\overline{CE}^*B^* \ge VDDQ - 0.2V^{(5)}$ VIN $\ge VDDQ - 0.2V$ or VIN $\le 0.2V$,	COM'L	S	690	770	515	640	460	520	mA
	Level Inputs)	Active Port, Outputs Disabled, $f = fMAX^{(1)}$	IND	S		_	515	660	460	545	
		•								56	628 tbl

NOTES:

1. At f = fmax, address and control lines (except Output Enable) are cycling at the maximum frequency clock cycle of 1/tcyc, using "AC TEST CONDITIONS" at input levels of GND to 3V.

- 2. f = 0 means no address, clock, or control lines change. Applies only to input at CMOS level standby.
- 3. Port "A" may be either left or right port. Port "B" is the opposite from port "A".
- 4. VDD = 3.3V, TA = 25°C for Typ, and are not production tested. IDD DC(f=0) = 120mA (Typ).
- "X" represents "L" for left port or "R" for right port.
- 6. 166MHz Industrial Temperature not available in BF-208 package.
- 7. This speed grade available when VDDQ = 3.3.V for a specific port (i.e., OPTx = VIH). This speed grade is available in BC-256 only.

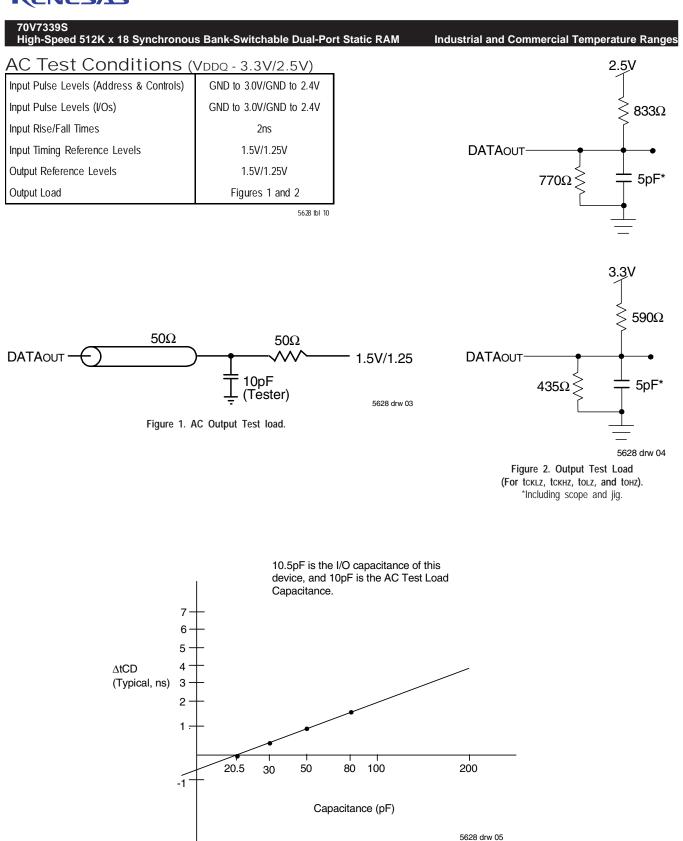


Figure 3. Typical Output Derating (Lumped Capacitive Load).

70V7339S High-Speed 512K x 18 Synchronous Bank-Switchable Dual-Port Static RAM

Industrial and Commercial Temperature Ranges

AC Electrical Characteristics Over the Operating Temperature Range (Read and Write Cycle Timing)^(2,3) (VDD = $3.3V \pm 150mV$, TA = 0°C to +70°C)

		70V733 Com	70V7339S200 ⁽⁵⁾ Com'l Only		70V7339S166 ^(3,4) Com'l & Ind		70V7339S133 ⁽³⁾ Com'l & Ind	
Symbol	Parameter	Min.	Max.	Min.	Max.	Min.	Мах.	Unit
tcyc1	Clock Cycle Time (Flow-Through) ⁽¹⁾	15	—	20		25	_	ns
tcyc2	Clock Cycle Time (Pipelined) ⁽¹⁾	5	—	6	—	7.5	_	ns
tCH1	Clock High Time (Flow-Through) ⁽¹⁾	5	—	6		7	_	ns
tCL1	Clock Low Time (Flow-Through) ⁽¹⁾	5	—	6		7	_	ns
tCH2	Clock High Time (Pipelined) ⁽²⁾	2.0	—	2.1		2.6	_	ns
tCL2	Clock Low Time (Pipelined) ⁽¹⁾	2.0	—	2.1	—	2.6	_	ns
tR	Clock Rise Time		1.5		1.5		1.5	ns
tF	Clock Fall Time		1.5		1.5		1.5	ns
tsa	Address Setup Time	1.5	—	1.7		1.8	_	ns
tha	Address Hold Time	0.5	—	0.5		0.5	_	ns
tsc	Chip Enable Setup Time	1.5	—	1.7		1.8	_	ns
tHC	Chip Enable Hold Time	0.5	—	0.5		0.5	_	ns
tsв	Byte Enable Setup Time	1.5	—	1.7		1.8		ns
tнв	Byte Enable Hold Time	0.5	—	0.5		0.5	_	ns
tsw	R/W Setup Time	1.5	_	1.7	—	1.8	_	ns
tHW	R/W Hold Time	0.5	—	0.5	_	0.5	_	ns
tsp	Input Data Setup Time	1.5	—	1.7	—	1.8	_	ns
thd	Input Data Hold Time	0.5	_	0.5	_	0.5	_	ns
tsad	ADS Setup Time	1.5	_	1.7	—	1.8	_	ns
thad	ADS Hold Time	0.5	—	0.5	_	0.5	_	ns
tscn	CNTEN Setup Time	1.5	—	1.7	_	1.8	_	ns
then	CNTEN Hold Time	0.5	_	0.5	_	0.5	_	ns
İ SRPT	REPEAT Setup Time	1.5	—	1.7	_	1.8	_	ns
t HRPT	REPEAT Hold Time	0.5	_	0.5	_	0.5	_	ns
toe	Output Enable to Data Valid		4.0		4.0		4.2	ns
tolz	Output Enable to Output Low-Z	0.5	_	0.5	_	0.5	_	ns
toнz	Output Enable to Output High-Z	1	3.4	1	3.6	1	4.2	ns
tCD1	Clock to Data Valid (Flow-Through) ⁽¹⁾		10		12		15	ns
tCD2	Clock to Data Valid (Pipelined) ⁽¹⁾		3.4	_	3.6		4.2	ns
tDC	Data Output Hold After Clock High	1	_	1	_	1	—	ns
tскнz	Clock High to Output High-Z	1	3.4	1	3.6	1	4.2	ns
tcklz	Clock High to Output Low-Z	0.5	_	0.5	_	0.5	_	ns
Port-to-Port D	lelay	•	-	•	-	-	-	.e
tco	Clock-to-Clock Offset	5.0	_	6.0	_	7.5	_	ns

1. The Pipelined output parameters (tcvc2, tcb2) apply to either or both left and right ports when \overline{FT} /PIPEx = VIH. Flow-through parameters (tcvc1, tcb1) apply when \overline{FT} /PIPEx = VIL for that port.

2. All input signals are synchronous with respect to the clock except for the asynchronous Output Enable (OE) and FT/PIPEx. FT/PIPEx should be treated as a DC signal, i.e. steady state during operation.

3. These values are valid for either level of VDDQ (3.3V/2.5V). See page 4 for details on selecting the desired operating voltage levels for each port.

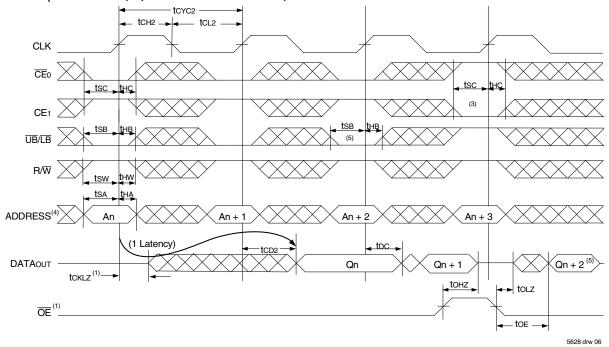
4. 166MHz Industrial Temperature not available in BF-208 package.

5. This speed grade available when VDD0 = 3.3.V for a specific port (i.e., OPTx = VIH). This speed grade available in BC-256 package only.

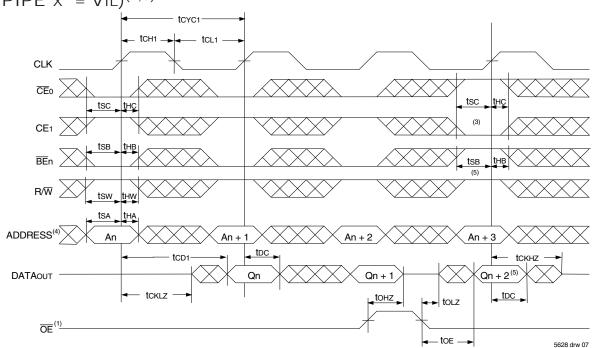
70V7339S High-Speed 512K x 18 Synchronous Bank-Switchable Dual-Port Static RAM

Industrial and Commercial Temperature Ranges

Timing Waveform of Read Cycle for Pipelined Operation (ADS Operation) (\overline{FT} /PIPE'X' = VIH)⁽²⁾

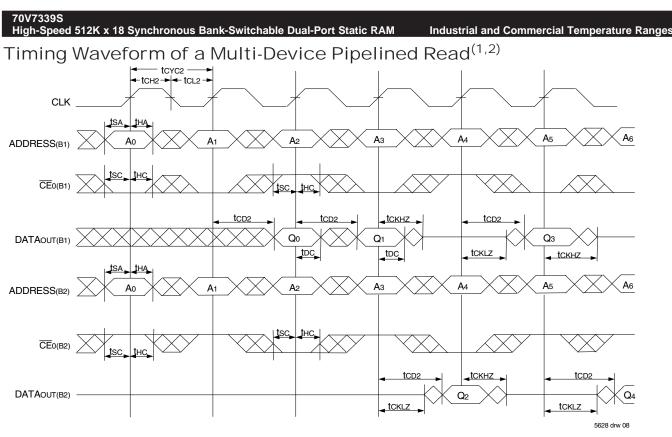




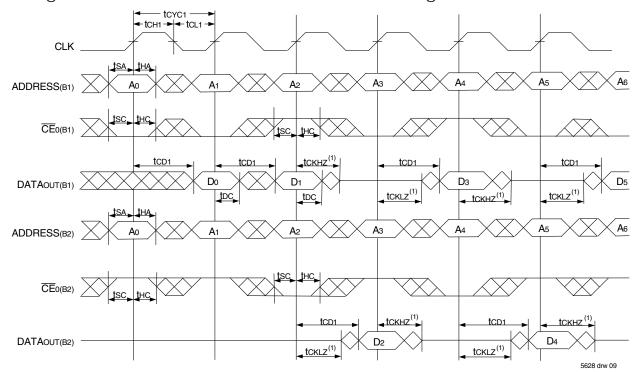


- 1. $\overline{\text{OE}}$ is asynchronously controlled; all other inputs are synchronous to the rising clock edge.
- 2. $\overline{\text{ADS}} = \text{VIL}, \overline{\text{CNTEN}} \text{ and } \overline{\text{REPEAT}} = \text{VIH}.$
- 3. The output is disabled (High-Impedance state) by $\overline{CE}_0 = V_{IH}$, $\overline{CE}_1 = V_{IL}$, $\overline{UB}/\overline{LB} = V_{IH}$ following the next rising edge of the clock. Refer to Truth Table 1.
- 4. Addresses do not have to be accessed sequentially since ADS = ViL constantly loads the address on the rising edge of the CLK; numbers are for reference use only.
- 5. If UB/LB was HIGH, then the appropriate Byte of DATAout for Qn + 2 would be disabled (High-Impedance state).
- 6. "x" denotes Left or Right port. The diagram is with respect to that port.





Timing Waveform of a Multi-Device Flow-Through Read^(1,2)



NOTES:

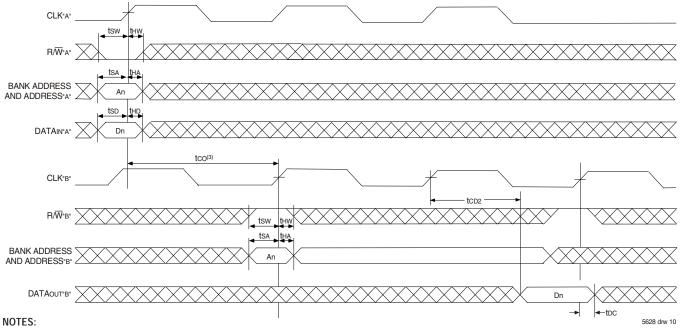
- B1 Represents Device #1; B2 Represents Device #2. Each Device consists of one IDT70V7339 for this waveform, and are setup for depth expansion in this example. ADDRESS(B1) = ADDRESS(B2) in this situation.
- 2. $\overline{UB/LB}$, \overline{OE} , and $\overline{ADS} = VIL$; CE1(B1), CE1(B2), R/W, \overline{CNTEN} , and $\overline{REPEAT} = VIH$.

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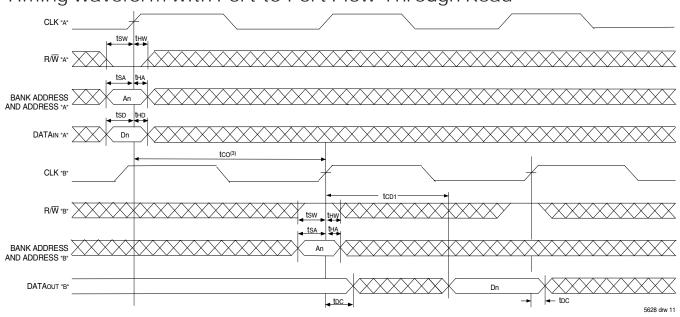
70V7339S High-Speed 512K x 18 Synchronous Bank-Switchable Dual-Port Static RAM Industrial and Comme

Industrial and Commercial Temperature Ranges

Timing Waveform of Port A Write to Pipelined Port B Read^(1,2,4)



- 1. \overline{CE}_{0} , \overline{BE}_{n} , and $\overline{ADS} = VIL$; CE1, \overline{CNTEN} , and $\overline{REPEAT} = VIH$.
- 2. $\overline{OE} = V_{IL}$ for the Right Port, which is being read from. $\overline{OE} = V_{IH}$ for the Left Port, which is being written to.
- If tco < minimum specified, then operations from both ports are INVALID. If tco ≥ minimum, then data from Port "B" read is available on first Port "B" clock cycle (ie, time from write to valid read on opposite port will be tco + tcyc2 + tcp2).
- 4. All timing is the same for both left and right ports. Port "A" may be either left or right port. Port "B" is the opposite of Port "A".



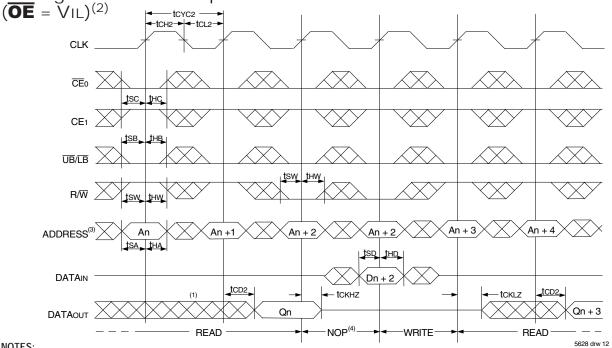
Timing Waveform with Port-to-Port Flow-Through Read^(1,2,4)

- 1. \overline{CE}_{0} , \overline{BE}_{n} , and $\overline{ADS} = VIL$; CE1, \overline{CNTEN} , and $\overline{REPEAT} = VIH$.
- 2. $\overline{OE} = V_{IL}$ for the Right Port, which is being read from. $\overline{OE} = V_{IH}$ for the Left Port, which is being written to.
- 3. If tco < minimum specified, then operations from both ports are INVALID. If tco ≥ minimum, then data from Port "B" read is available on first Port "B" clock cycle (i.e., time from write to valid read on opposite port will be tco + tcc1).
- 4. All timing is the same for both left and right ports. Port "A" may be either left or right port. Port "B" is the opposite of Port "A".



70V7339S High-Speed 512K x 18 Synchronous Bank-Switchable Dual-Port Static RAM Industrial and Commercial Temperature Ranges

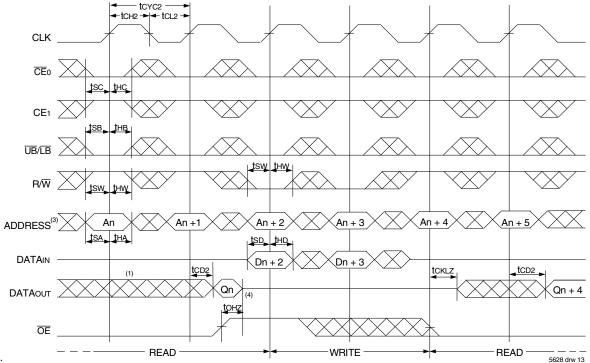
Timing Waveform of Pipelined Read-to-Write-to-Read



NOTES:

- Output state (High, Low, or High-impedance) is determined by the previous cycle control signals. 1.
- CEo, BEn, and ADS = VIL; CE1, CNTEN, and REPEAT = VIH. "NOP" is "No Operation". 2.
- 3. Addresses do not have to be accessed sequentially since ADS = VIL constantly loads the address on the rising edge of the CLK; numbers are for reference use only.
- 4. "NOP" is "No Operation." Data in memory at the selected address may be corrupted and should be re-written to guarantee data integrity.

Timing Waveform of Pipelined Read-to-Write-to-Read (**OE** Controlled)⁽²⁾



NOTES:

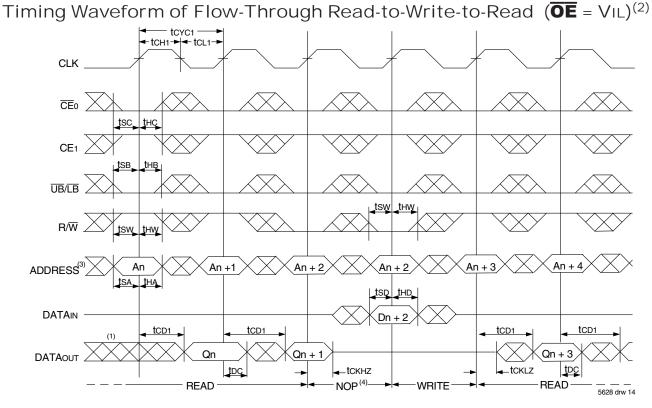
1. Output state (High, Low, or High-impedance) is determined by the previous cycle control signals.

- \overline{CE}_0 , $\overline{UB}/\overline{LB}$, and \overline{ADS} = VIL; CE1, \overline{CNTEN} , and \overline{REPEAT} = VIH. 2.
- 3. Addresses do not have to be accessed sequentially since ADS = VIL constantly loads the address on the rising edge of the CLK; numbers are for reference use only.

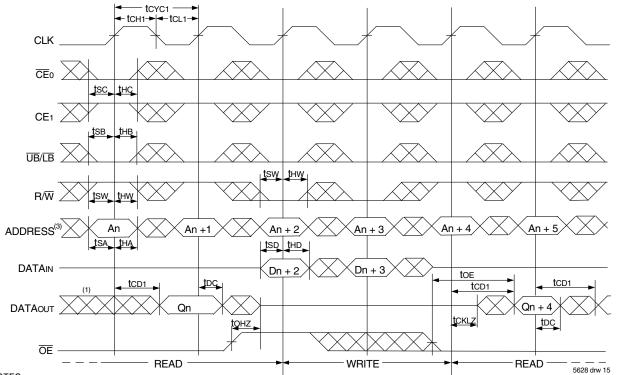
This timing does not meet requirements for fastest speed grade. This waveform indicates how logically it could be done if timing so allows. 4







Timing Waveform of Flow-Through Read-to-Write-to-Read (**OE** Controlled)⁽²⁾

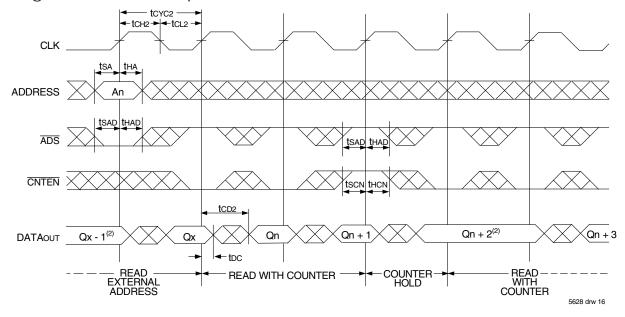


- 1. Output state (High, Low, or High-impedance) is determined by the previous cycle control signals.
- 2. \overline{CE}_0 , $\overline{UB}/\overline{LB}$, and $\overline{ADS} = VIL$; CE_1 , \overline{CNTEN} , and $\overline{REPEAT} = VIH$.
- 3. Addresses do not have to be accessed sequentially since ADS = VIL constantly loads the address on the rising edge of the CLK; numbers are for reference use only.
- 4. "NOP" is "No Operation." Data in memory at the selected address may be corrupted and should be re-written to guarantee data integrity.

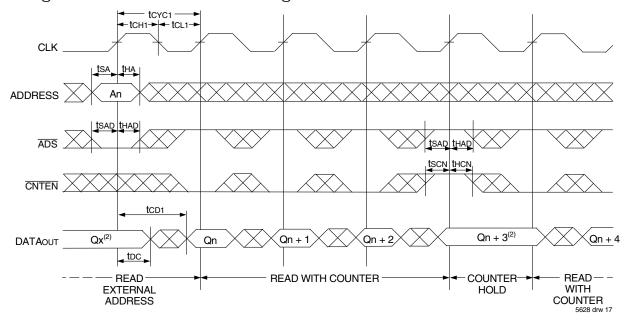


70V7339S High-Speed 512K x 18 Synchronous Bank-Switchable Dual-Port Static RAM Industrial and Commercial Temperature Ranges

Timing Waveform of Pipelined Read with Address Counter Advance⁽¹⁾



Timing Waveform of Flow-Through Read with Address Counter Advance⁽¹⁾

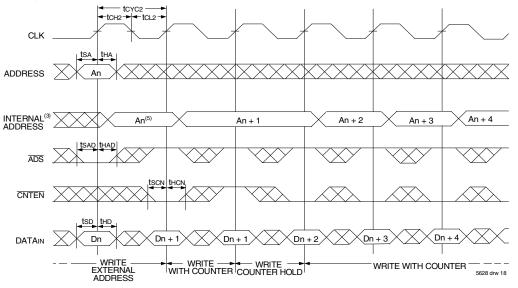


- 1. \overline{CE}_{0} , \overline{OE} , $\overline{UB}/\overline{LB}$ = VIL; CE1, R/W, and \overline{REPEAT} = VIH.
- 2. If there is no address change via \overline{ADS} = VIL (loading a new address) or \overline{CNTEN} = VIL (advancing the address), i.e. \overline{ADS} = VIH and \overline{CNTEN} = VIH, then the data output remains constant for subsequent clocks.

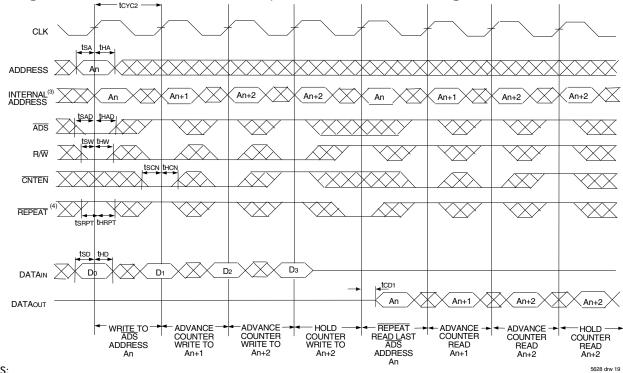


70V7339S High-Speed 512K x 18 Synchronous Bank-Switchable Dual-Port Static RAM

Timing Waveform of Write with Address Counter Advance (Flow-through or Pipelined Inputs)^(1,6)



Timing Waveform of Counter Repeat for Flow Through Mode^(2,6,7)



- 1. \overline{CE}_{0} , $\overline{UB}/\overline{LB}$, and $R/\overline{W} = V_{IL}$; CE1 and $\overline{REPEAT} = V_{IH}$.
- 2. \overline{CE}_{0} , $\overline{UB}/\overline{LB} = VIL$; $CE_{1} = VIH$.
- 3. The "Internal Address" is equal to the "External Address" when ADS = VIL and equals the counter output when ADS = VIH.
- 4. No dead cycle exists during REPEAT operation. A READ or WRITE cycle may be coincidental with the counter REPEAT cycle: Address loaded by last valid ADS load will be accessed. For more information on REPEAT function refer to Truth Table II.
- 5. CNTEN = VIL advances Internal Address from 'An' to 'An +1'. The transition shown indicates the time required for the counter to advance. The 'An +1'Address is written to during this cycle.
- 6. The counter includes bank address and internal address. The counter will advance across bank boundaries. For example, if the counter is in Bank 0, at address FFFh, and is advanced one location, it will move to address 0h in Bank 1. By the same token, the counter at FFFh in Bank 63 will advance to 0h in Bank 0.
- 7. For Pipelined Mode user should add 1 cycle latency for outputs as per timing waveform of read cycle for pipelined operations.

70V7339S High-Speed 512K x 18 Synchronous Bank-Switchable Dual-Port Static RAM

Functional Description

The IDT70V7339 is a high-speed 512Kx18 (9 Mbit) synchronous Bank-Switchable Dual-Ported SRAM organized into 64 independent 8Kx18 banks. Based on a standard SRAM core instead of a traditional true dual-port memory core, this bank-switchable device offers the benefits of increased density and lower cost-per-bit while retaining many of the features of true dual-ports. These features include simultaneous, random access to the shared array, separate clocks per port, 166 MHz operating speed, full-boundary counters, and pinouts compatible with the IDT70V3319 (256Kx18) dual-port family.

The two ports are permitted independent, simultaneous access into separate banks within the shared array. Access by the ports into specific banks are controlled by the bank address pins under the user's direct control: each port can access any bank of memory with the shared array that is not currently being accessed by the opposite port (i.e., BAOL - BA5L \neq BAOR - BA5R). In the event that both ports try to access the same bank at the same time, neither access will be valid, and data at the two specific addresses targeted by the ports within that bank may be corrupted (in the case that either or both ports are writing) or may result in invalid output (in the case that both ports are trying to read).

The IDT70V7339 provides a true synchronous Dual-Port Static RAM interface. Registered inputs provide minimal setup and hold times on address, data and all critical control inputs.

Industrial and Commercial Temperature Ranges

An asynchronous output enable is provided to ease asynchronous bus interfacing. Counter enable inputs are also provided to stall the operation of the address counters for fast interleaved memory applications.

A HIGH on \overline{CE}_0 or a LOW on CE1 for one clock cycle will power down the internal circuitry on each port (individually controlled) to reduce static power consumption. Dual chip enables allow easier banking of multiple IDT70V7339s for depth expansion configurations. Two cycles are required with \overline{CE} 0 LOW and CE1 HIGH to read valid data on the outputs.

Depth and Width Expansion

The IDT70V7339 features dual chip enables (refer to Truth Table I) in order to facilitate rapid and simple depth expansion with no requirements for external logic. Figure 4 illustrates how to control the various chip enables in order to expand two devices in depth.

The IDT70V7339 can also be used in applications requiring expanded width, as indicated in Figure 4. Through combining the control signals, the devices can be grouped as necessary to accommodate applications needing 36-bits or wider.

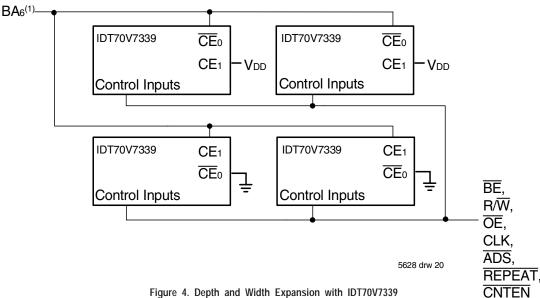


Figure 4. Depth and Width Expansion with IDT70V7339

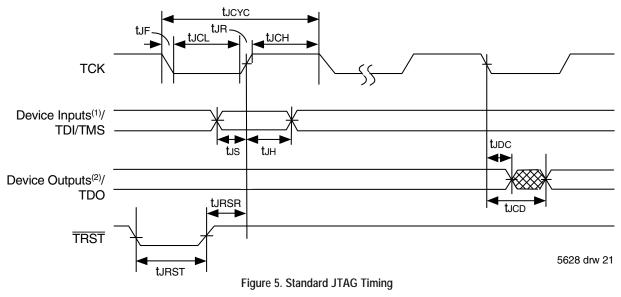
NOTE:

1. In the case of depth expansion, the additional address pin logically serves as an extension of the bank address. Accesses by the ports into specific banks are controlled by the bank address pins under the user's direct control: each port can access any bank of memory within the shared array that is not currently being accessed by the opposite port (i.e., BAoL - BAoL - BAoR - BAoR). In the event that both ports try to access the same bank at the same time, neither access will be valid, and data at the two specific addresses targeted by the parts within that bank may be corrupted (in the case that either or both parts are writing) or may result in invalid output (in the case that both ports are trying to read).

70V7339S High-Speed 512K x 18 Synchronous Bank-Switchable Dual-Port Static RAM

Industrial and Commercial Temperature Ranges

JTAG Timing Specifications



NOTES:

1. Device inputs = All device inputs except TDI, TMS, TRST, and TCK.

2. Device outputs = All device outputs except TDO.

		70V7339		
Symbol	Parameter	Min.	Мах.	Units
tucyc	JTAG Clock Input Period	100	_	ns
исн	JTAG Clock HIGH	40		ns
tJCL	JTAG Clock Low	40		ns
tır	JTAG Clock Rise Time		3(1)	ns
IJF	JTAG Clock Fall Time		3(1)	ns
URST	JTAG Reset	50	_	ns
URSR	JTAG Reset Recovery	50		ns
ticd	JTAG Data Output		25	ns
tidc	JTAG Data Output Hold	0	_	ns
tis	JTAG Setup	15		ns
tн	JTAG Hold	15		ns

JTAG AC Electrical Characteristics^(1,2,3,4)

NOTES:

1. Guaranteed by design.

2. 30pF loading on external output signals.

3. Refer to AC Electrical Test Conditions stated earlier in this document.

4. JTAG operations occur at one speed (10MHz). The base device may run at any speed specified in this datasheet.

5628 tbl 12

70V7339S

High-Speed 512K x 18 Synchronous Bank-Switchable Dual-Port Static RAM

Industrial and Commercial Temperature Ranges

Identification Register Definitions

Instruction Field	Value	Description
Revision Number (31:28)	0x0	Reserved for version number
IDT Device ID (27:12)	0x301	Defines IDT part number
IDT JEDEC ID (11:1)	0x33	Allows unique identification of device vendor as IDT
ID Register Indicator Bit (Bit 0)	1	Indicates the presence of an ID register

5628 tbl 13

5628 tbl 15

Scan Register Sizes

Register Name	Bit Size
Instruction (IR)	4
Bypass (BYR)	1
Identification (IDR)	32
Boundary Scan (BSR)	Note (3)

5628 tbl 14

System Interface Parameters

Instruction	Code	Description
EXTEST	0000	Forces contents of the boundary scan cells onto the device outputs ⁽¹⁾ . Places the boundary scan register (BSR) between TDI and TDO.
BYPASS	1111	Places the bypass register (BYR) between TDI and TDO.
IDCODE	0010	Loads the ID register (IDR) with the vendor ID code and places the register between TDI and TDO.
HIGHZ	0100	Places the bypass register (BYR) between TDI and TDO. Forces all device output drivers to a High-Z state.
CLAMP	0011	Uses BYR. Forces contents of the boundary scan cells onto the device outputs. Places the bypass register (BYR) between TDI and TDO.
SAMPLE/PRELOAD	0001	Places the boundary scan register (BSR) between TDI and TDO. SAMPLE allows data from device inputs ⁽²⁾ and outputs ⁽¹⁾ to be captured in the boundary scan cells and shifted serially through TDO. PRELOAD allows data to be input serially into the boundary scan cells via the TDI.
RESERVED	All other codes	Several combinations are reserved. Do not use codes other than those identified above.

NOTES:

1. Device outputs = All device outputs except TDO.

2. Device inputs = All device inputs except TDI, TMS, TRST, and TCK.

3. The Boundary Scan Descriptive Language (BSDL) file for this device is available on the IDT website (www.idt.com), or by contacting your local IDT sales representative.

70V7339S High-Speed 512K x 18 Synchronous Bank-Switchable Dual-Port Static RAM Industrial and Commercial Temperature Ranges Ordering Information XXXXX А 999 А А А А Device Package Process/ Power Speed Temperature Range Type Blank Tray Tape and Reel 8 Commercial (0°C to +70°C) Industrial (-40°C to +85°C) Blank **I**(4) G⁽³⁾ Green 208-pin fpBGA (BF208, BFG208) 256-pin BGA (BC256, BCG256) BF BC Commercial Only⁽¹⁾ 200 Commercial & Industrial⁽²⁾ Speed in Megahertz 166 133 Commercial & Industrial S Standard Power 70V7339 9Mbit (512K x 18-Bit) Synchronous Bank-Switchable Dual-Port RAM

5628 drw 22

NOTES:

1. Available in BC-256 package only.

- 2. Industrial Temperature at 166MHz not available in the BF-208 package.
- 3. Green parts available. For specific speeds, packages and powers contact your local sales office.

4. Contact your local sales office for industrial temp range for other speeds, packages and powers

Speed (MHz)	Orderable Part ID	Pkg. Code	Pkg. Type	Temp. Grade
133	70V7339S133BC	BC256	CABGA	С
	70V7339S133BC8	BC256	CABGA	С
	70V7339S133BCI	BC256	CABGA	I
	70V7339S133BCI8	BC256	CABGA	Ι
	70V7339S133BF	BF208	CABGA	С
	70V7339S133BF8	BF208	CABGA	С
	70V7339S133BFI	BF208	CABGA	I
	70V7339S133BF18	BF208	CABGA	I
166	70V7339S166BC	BC256	CABGA	С
	70V7339S166BC8	BC256	CABGA	С
	70V7339S166BCGI	BCG256	CABGA	I
	70V7339S166BCI	BC256	CABGA	I
	70V7339S166BCl8	BC256	CABGA	I
	70V7339S166BF	BF208	CABGA	С
	70V7339S166BF8	BF208	CABGA	С
	70V7339S166BFG	BFG208	CABGA	С
	70V7339S166BFG8	BFG208	CABGA	С
200	70V7339S200BC	BC256	CABGA	С
	70V7339S200BC8	BC256	CABGA	С

Orderable Part Information

70V7339S High-Speed 512K x 18 Synchronous Bank-Switchable Dual-Port Static RAM

Datasheet Document History

01/05/00: 06/20/01:	5
08/06/01:	Page 4 Changed body size for DD package from 22mm x 22mm x1.6mm to 20mm x 20mm x 1.4mm Page 9 Changed IsB3 values for commercial and industrial DC Electrical Characteristics
11/20/01:	Page 2, 3 & 4 Added date revision for pin configurations Page 11 Changed toE value in AC Electrical Characteristics, please refer to Errata #SMEN-01-05 Page 1 & 22 Replaced TM logo with ® logo
03/18/02:	Page 1, 9, 11 & 22 Added 200MHZ specification Page 9 Tightened power numbers in DC Electrical Characteristics Page 14 Changed waveforms to show INVALID operation if tco < minimum specified Page 1 - 22 Removed "Preliminary" status
12/04/02:	Page 9, 11 & 22 Designated 200Mhz speed grade in BC-256 package only
01/16/04:	
07/25/08:	Page 9 Corrected a typo in the DC Chars table
01/29/09:	Page 22 Removed "IDT" from orderable part number
04/20/10:	Page 1 Added green availability to features Page 21 Added green indicator to ordering information Removed the DD 144-pin TQFP (DD-144) Thin Quad Flatpack per PDN: F-08-01
08/11/15:	Page 2 & 3 Removed the date from all of the pin configurations BF208 & BC256 Page 21 Added T&R indicator and updated footnotes for Ordering Information
06/22/18:	Product Discontinuation Notice - PDN# SP-17-02 Last time buy expires June 15, 2018
10/22/19:	Page 2 & 3 Updated package codes Page 21 Added Orderable Part Information

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